

**Notice of References Cited**

Application/Control No.

10/590,002

Applicant(s)/Patent Under  
Reexamination  
DEUTSCH ET AL.

Examiner

MYRON WYCHE

Art Unit

2617

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0111476	06-2004	Trossen et al.	709/206
*	C	US-2004/0198279	10-2004	Anttila et al.	455/179.1
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**FOREIGN PATENT DOCUMENTS**

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